

# FDC637AN

# Single N-Channel, 2.5V Specified PowerTrench™ MOSFET

## **General Description**

This N-Channel 2.5V specified MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain low gate charge for superior switching performance.

These devices have been designed to offer exceptional power dissipation in a very small footprint compared with bigger SO-8 and TSSOP-8 packages.

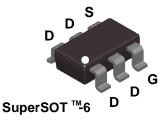
## **Applications**

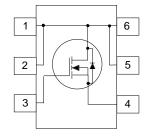
- DC/DC converter
- Load switch
- Battery Protection

### **Features**

• 6.2 A, 20 V. 
$$R_{DS(on)} = 0.024~\Omega~$$
 @  $V_{GS} = 4.5~V$   $R_{DS(on)} = 0.032~\Omega~$  @  $V_{GS} = 2.5~V$ 

- Fast switching speed.
- Low gate charge (10.5nC typical).
- $\bullet \;\;$  High performance trench technology for extremely low  $R_{_{DS(ON)}}.$
- SuperSOT<sup>TM</sup>-6 package: small footprint (72% smaller than standard SO-8); low profile (1mm thick).





# Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		FDC637AN	Units
V <sub>DSS</sub>	Drain-Source Voltage		20	V
$V_{GSS}$	Gate-Source Voltage		±8	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	6.2	А
	Drain Current - Pulsed		20	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	1.6	W
		(Note 1b)	0.8	7
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

## **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	30	°C/W

## **Package Outlines and Ordering Information**

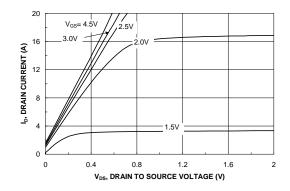
Device Marking	Device	Reel Size	Tape Width	Quantity
.637 FDC637AN		7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		•	•		
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V
ΔBV <sub>DSS</sub> ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu A$ , Referenced to $25^{\circ}C$		14		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 16 V, V <sub>GS</sub> = 0 V			1	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -8 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)			-		
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	0.4	0.82	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> =250μA,Referenced to 125°C		-3		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 6.2 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 6.2 \text{ A}, T_J = 125^{\circ}\text{C}$ $V_{GS} = 2.5 \text{ V}, I_D = 5.2 \text{ A}$		0.019 0.028 0.025	0.024 0.041 0.032	Ω
I <sub>D(on)</sub>	On-State Drain Current	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 5 V	10			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 6.2 \text{ A}$		7.4		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$		1125		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		290		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			145		pF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$		9	18	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 6 \Omega$		13	24	ns
$t_{d(off)}$	Turn-Off Delay Time			26	42	ns
t <sub>f</sub>	Turn-Off Fall Time			11	20	ns
Qg	Total Gate Charge	$V_{DS} = 5 \text{ V}, I_{D} = 6.2 \text{ A},$		10.5	16	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 4.5 V		1.5		nC
$Q_{gd}$	Gate-Drain Charge			2.2		nC
Drain-Sc	ource Diode Characteristics a	and Maximum Ratings				
Is	Maximum Continuous Drain-Source Di				1.3	Α
V <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 1.3 A (Note 2)	<del>                                     </del>	0.7	1.2	V

## Notes:

- 1.  $R_{\theta,JA}$  is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta,JC}$  is guaranteed by design while  $R_{\theta,CA}$  is determined by the user's board design.
  - a)  $78^{\circ}$  C/W when mounted on a 1.0 in  $^{\!2}$  pad of 2 oz. copper.
  - b) 156° C/W when mounted on a minimum pad of 2 oz.copper.
- 2. Pulse Test: Pulse Width  $\leq 300~\mu s,~Duty~Cycle \leq 2.0\%$

# **Typical Characteristics**



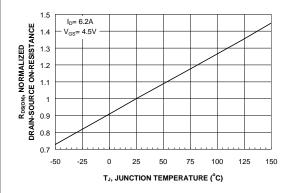
2.5 V ORAIN CURRENT (A)

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1.5 V ORAIN CURRENT (A)

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



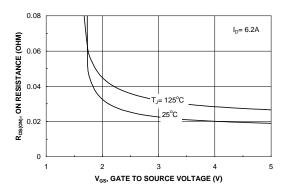
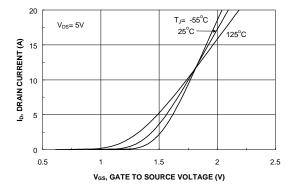


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



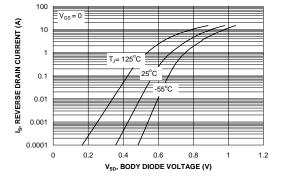
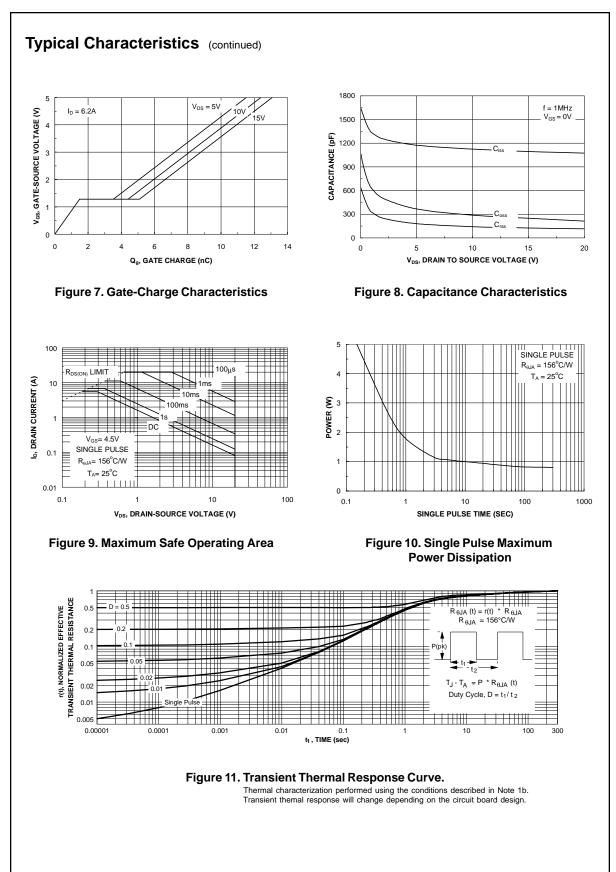


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

FDC637AN, Rev. C



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Rev. [